

INTRODUCTION

- 1. The contents is subject to change without notice. Please exchange the specification sheets regarding the product's warranty.
- 2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
- 3. We have prepared this sheet as carefully as possible. If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

This product is compliant with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes. Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

Product No. / Model

The product No. of this crystal oscillator unit is Q33310F70062200. The model is SG-310SCF.

Contents

Item No.	Item	Page
[1]	Absolute maximum ratings	2
[2]	Operating range	2
[3]	Frequency characteristics	2
[4]	Terminal assignment	3
[5]	Electrical characteristics	4
[6]	Test circuit	5
[7]	Timing chart	6-7
[8]	Environmental and mechanical characteristics	8
[9]	Moisture sensitivity and ESD sensitivity	9
[10]	Dimensions and marking layout	10
[11]	Notes	11
[12]	Recommendable patterning	12

[1] Absolute maximum ratings

Parameter	Symbol	Value	Unit	Note
Supply voltage	Vcc-GND	-0.3 to +4.2	V	
Storage temperature *	T_stg	-40 to +125	°C	Stored as bare product after unpacking.
Input voltage	Vin	-0.3 to Vcc+0.3	V	ST Terminal

* Concerning the frequency change, please refer [8] Environmental and mechanical characteristics.

[2] Operating range

			Value			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note
Supply voltage	Vcc	2.7	3.3	3.6	V	
Supply voltage	GND	0.0	0.0	0.0	V	
Input voltage	Vin	GND	-	Vcc	V	
Operating temperature	T_use	-40	+25	+85	°C	
Output load condition	L_CMOS	-	-	15	pF	

• Start up time(0 % Vcc \rightarrow 90 % Vcc) of power source should be more than 150 μ s.

• By-pass capacitor (0.01 μF to 0.1 μF) is connected near Vcc between Vcc and GND. (Refer to [12] Recommendable patterning)

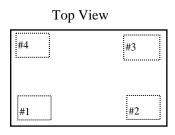
[3] Frequency characteristics

Output frequency (Fo) 50 MHz

Parameter	Symbol	Value $[1 \times 10^{-6}]$	Note
Frequency tolerance *	F_tol (OSC)	L:±50	T_use=-40 °C to +85 °C
Aging	F_aging	+ 5	T_use=+25 °C, Vcc=3.3 V First year

* This includes initial frequency tolerance, temperature characteristics, input voltage characteristics, and load characteristics, but excludes aging.

[4] Terminal assignment



Terminal name	Terminal No.	Terminal type.
ST	1	INPUT
GND	2	—
OUT	3	OUTPUT
Vcc	4	—

 \overline{ST} pin : High or open. \rightarrow Specified frequency output = enable.

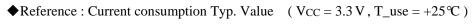
 \overline{ST} pin : Low. \rightarrow Output is high impedance = disabled.

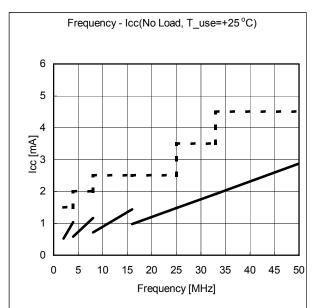
[5] Electrical characteristics

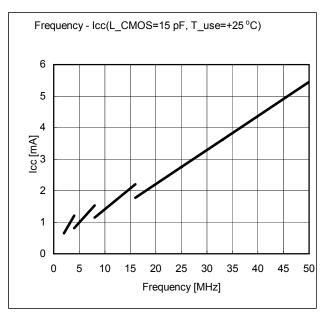
(Please see page 2 [2] Operating range)

		Va	lue			
Parameter	Symbol	Min.	Max.	Unit	Note	
Start up time	tosc	-	10	ms	t=0 at 90 % VCC	
Current consumption	ICC	-	4.5	mA	No load	
Standby current	I_std	-	2.0	μΑ	ST =GND	
Output rise time	tr	-	4.0	ns	$20 \% \text{Vcc} \rightarrow 80 \% \text{Vcc}$	
Output fall time	tf	-	4.0	ns	$80 \% \text{Vcc} \rightarrow 20 \% \text{Vcc}$	
Symmetry	SYM	45	55	%	50 %Vcc Level	
High level output voltage	Vон	0.9 Vcc	-	V	IOH = -3 mA	
Low level output voltage	Vol	-	0.1 Vcc	V	IOL = 3 mA	
High level input voltage	Vih	0.8 Vcc	-	V	ST terminal	
Low level input voltage	VIL	-	0.2 Vcc	V	ST terminal	
Input current	Іін	-	1.0	μΑ	VIN = VCC	
	IIL	-1.0	-	μΑ	Vin = GND	
Output disable time	tstp	-	100	ns	$\overline{\text{ST}}$ terminal High \rightarrow Low	
Output enable time	tsta	-	10	ms	$\overline{\text{ST}}$ terminal Low \rightarrow High	
Input pull-up resistance	RUP	4	35	MΩ	V _{IN} =GND	
		25	55	kΩ	VIN =0.8 Vcc	

Refer to [6] Test circuit [7] Timing chart

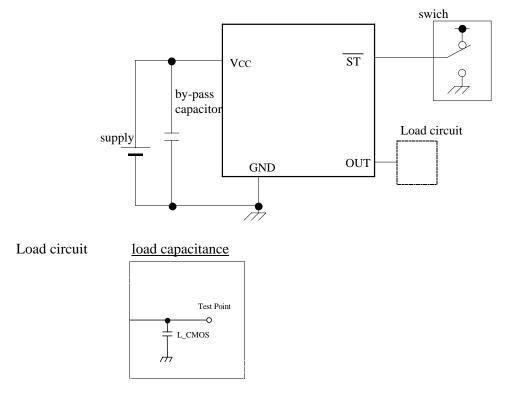




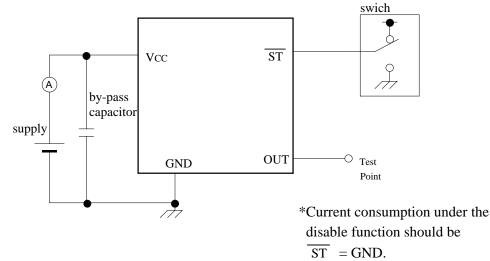


[6] Test circuit

1) Waveform observation



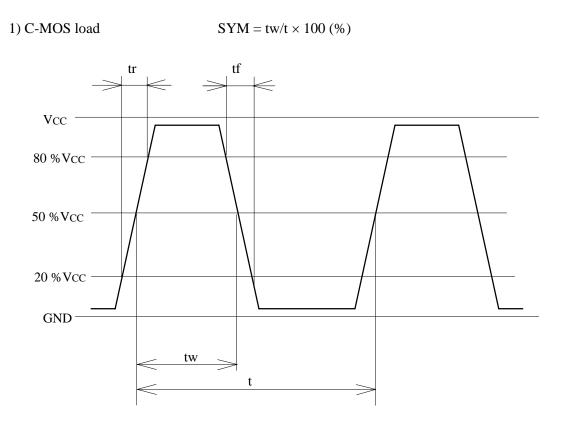
2) Current consumption



3) Condition

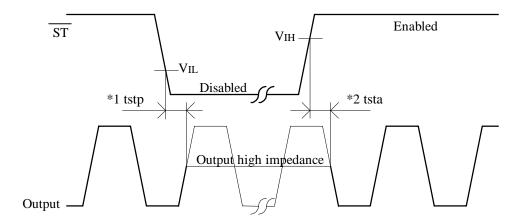
- (1) Oscilloscope
 - Band width should be minimum 5 times higher (wider) than measurement frequency.
 - Probe earth should be placed closely from test point and lead length should be as short as possible.
 - * Recommendable to use miniature socket. (Don't use earth lead.)
- (2) L_CMOS also includes probe capacitance.
- (3) By-pass capacitor (0.01 μ F to 0.1 μ F) is placed closely between Vcc and GND.
- (4) Use the current meter whose internal impedance value is small.
- (5) Power supply
 - Start up time (0 %Vcc \rightarrow 90 %Vcc) of power source should be more than 150 µs.
 - Impedance of power supply should be as lowest as possible.

[7] Timing chart



2) ST function and timing

ST function	Osc. circuit	Output status				
High or Open Oscillation		Specified frequency is output : Enable				
Low Oscillation stop		Output becomes high impedance : Disable				

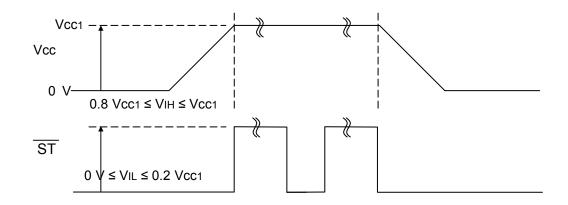


*1 The time taken from $\overline{ST} = VIL$ to output = Disable (high impedance) *2 The time taken from $\overline{ST} = VIH$ to output = Start

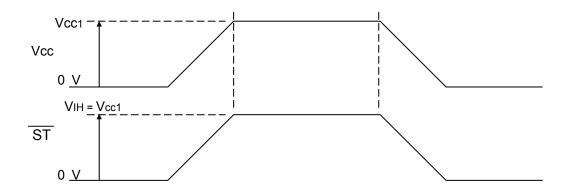
Output start : Voh ≥ 0.8 %Vcc, Vol ≤ 0.2 %Vcc, Fout = Fo $\pm 1.000 \times 10^{-6}$

3) ST Control timing

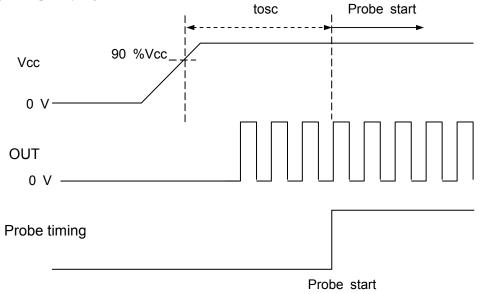
- ST function is used on the voltage below supply voltage.
 - ST control timing differs from Vcc control timing



ST terminal is connected to Vcc terminal



4) Timing of an output frequency signal



[8] Environmental and mechanical characteristics

τ.	Value *1		Test Conditions		
Item	$\Delta f / f *2$ [1 × 10 ⁻⁶]	Electrical characteristics			
High temperature storage	*3 ±50		+125 °C × 1 000 h		
Low temperature storage	*3 ±10		-40 °C × 1 000 h		
High temperature bias	*3 ±20		+85 °C × V Max. × 1 000 h		
Low temperature bias	*3 ±10		-40 °C × V Max. × 1 000 h		
Temperature humidity bias	*3 ±20		+85 °C × 85 %RH × V Max. × 1 000 h		
Temperature cycle	*3 ±20		$-40 \text{ °C} \leftrightarrow +125 \text{ °C}$ 30 min. at each temperature 100 cycles		
Resistance to soldering heat	± 10		Convection reflow soldering furnace (3 time) Ref. IPC/JEDEC J-STD-020D.1		
Shock	±5	Satisfy Item [5] after test.	100 g dummy Jig (SE Standard) drop from 1 500 mm height on the Concrete 3 directions 10 times.		
Vibration	±10		10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min./cycle 6 h (2 hours , 3 directions)		
Seal	1 × 10 ⁻⁹	$Pa \cdot m^3 / s$	He leakage detector		
Pull - off			10 N press for 10 s ± 1 s Ref. EIAJ ED-4702		
Solderability			Dip termination into solder bath at $+235 \text{ °C} \pm 5 \text{ °C}$ for 5 s. (Using Rosin Flux)		
	Low temperature storage High temperature bias Low temperature bias Temperature humidity bias Temperature cycle Resistance to soldering heat Shock Vibration Seal Pull - off	High temperature storage*3 ± 50 Low temperature storage*3 ± 10 High temperature bias*3 ± 20 Low temperature bias*3 ± 10 Temperature humidity bias*3 ± 20 Temperature cycle*3 ± 20 Resistance to soldering heat ± 10 Shock ± 5 Vibration ± 10 Seal 1×10^{-9} Pull - offNo peeling-of paSolderabilityTermination m covered with f	High temperature storage*3 ± 50 Low temperature storage*3 ± 10 High temperature bias*3 ± 20 Low temperature bias*3 ± 20 Low temperature humidity bias*3 ± 20 Temperature cycle*3 ± 20 Resistance to soldering heat ± 10 Shock ± 5 SatisfyItem [5] after test.Item [5] after test.Vibration ± 10 1×10^{-9} Pa·m ³ /sPull - offNo peeling-off at a solder partSolderabilityTermination must be 95 % covered with fresh solder		

(The company evaluation condition We evaluate it by the following examination item and examination condition.)

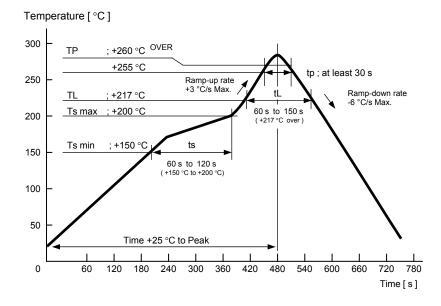
< Notes >

*1 Each test done independently.

*2 Measuring 2 h to 24 h later leaving in room temperature after each test.

*3 Initial value shall be measured after 24 h storage at room temperature after pre-conditioning. Pre-conditioning: Reflow (3 time)

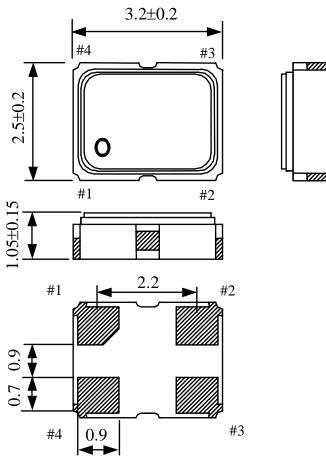
Convection reflow condition (Ref. IPC/JEDEC J-STD-020D.1)



[9] Dimensions and marking layout

1) Dimensions

2) Marking layout



Terminal treatment : Au plating Unit : mm

- Symbol mark E50.00L Frequency tolerance #1pin 07F4811 Production Lot number
- The above marking layout shows only marking contents and their approximate position and it is not for font, size and exact position.
- Output frequency shall indicate 5 digits (include decimal point), if the value of frequency over 5 digits, the least significant digits will be omitted.

9

[10] Notes

1) This device is made with C-MOS IC.

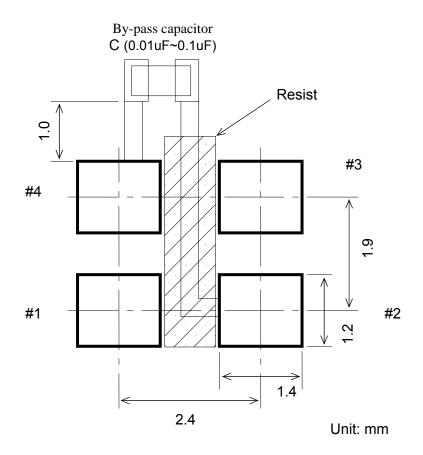
Please take necessary precautions to prevent damage due to electrical static discharge.

- 2) SEIKO EPSON recommends a 0.01 µF to 0.1 µF capacitor must be connected near Vcc between Vcc and GND to obtain stable operation and protect against power line ripple. (Refer to [12] Recommendable patterning)
- 3) Vcc and GND pattern shall be as large as possible so that high frequency impedance shall be small.
- 4) SEIKO EPSON cannot recommend to put filtering element into power line so as to reduce noise. Oscillator might be unstable oscillation because high frequency impedance of power line become higher. When use filtering element, please verify electrical construction and or element's spec.
- 5) SEIKO EPSON doesn't recommend to power on from intermediate electric voltage or extreme fast power on, Those powering conditions may cause no oscillation or abnormal oscillation.
- 6) Power ripple: 200 mV P-P max. Start up time (0 %Vcc→90 %Vcc) of power source should be more than 150 μs.
- 7) A long output line may cause irregular output, so try to make the output line as short as possible.
- 8) Other high-level signal lines may cause incorrect operation, so please do not place high level signal line close to this device.
- 9) This device contains a crystal resonator, so please don't expose excessive shock or vibration. SEIKO EPSON recommends store device under normal temperature and humidity to keep the specification.
- 10) An automatic insertion is available, however, the internal crystal resonator might be damaged in case that too much shock or vibration is applied by machine condition.Be sure to check your machine condition in advance.
- 11) Ultrasonic cleaning can be used on the SG-310SCF, however, since the oscillator might be damaged under some conditions, please exercise in advance.
- 12) SEIKO EPSON recommends to use and store under room temperature and normal humidity to secure frequency accuracy and prevent moisture.
- 13) ST -pin has pull-up resistor internally. The resistor value is switched depending on input voltage.
 Please refer to electrical characteristics.

[11] Recommendable patterning

The soldering pad sample indicated as like following:

Soldering position (Unit : mm)



TAPING SPECIFICATION

I. Application

This standard will apply to 3.2×2.5 Ceramic package. Spec : CE package

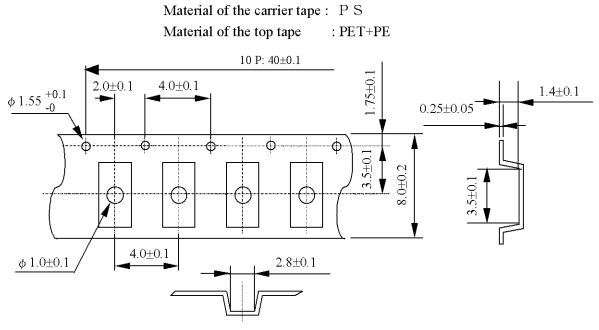
${\rm I\hspace{-1.5mm}I}$. Contents

Item No.	Item	Page
[1]	Taping specification	1 to 2
[2]	Inner carton	3
[3]	Shipping carton	
[4]	Marking	4
[5]	Quantity	
[6]	Storage environment	
[7]	Handling	

[1] Taping specification

Subject to **[EIA-481]** and **[IEC-60286]**

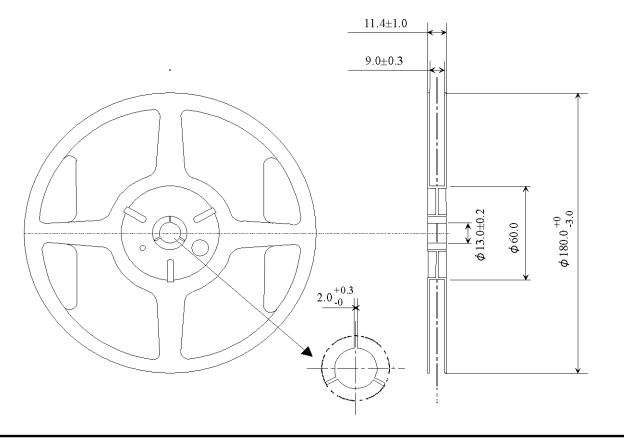
(1) Tape dimensions

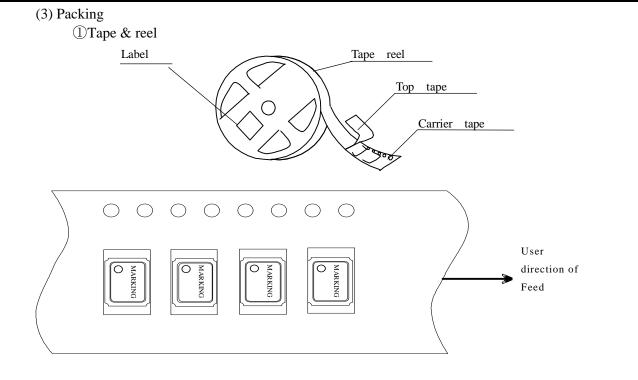


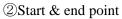
Unit : mm

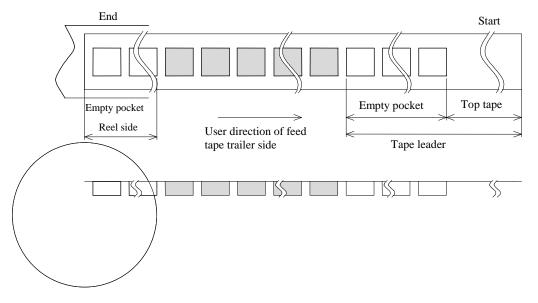
(2) Reel dimensions

Material of the reel : Conductive polystyrene

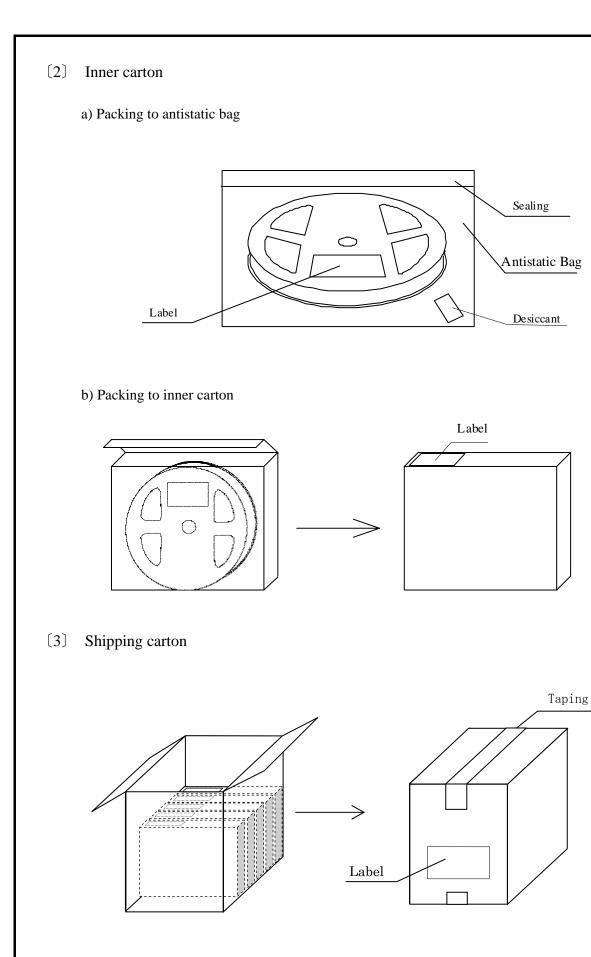








	Item	Empty space
Tape leader	Top tape	Min. 1 000 mm
	Carrier tape	Min. 160 mm
Tape trailer	Top tape	Min. 0 mm
	Carrier tape	Min. 160 mm



P. 3

[4] Marking

- (1) Reel marking
 - Reel marking shall consist of :
 - 1) Parts name
 - 2) Quantity
 - 3) Manufacturing date or symbol
 - 4) Manufacturer's date or symbol
 - 5) Others (if necessary)
- (2) Inner carton marking
 - Same as reel marking.
- (3) Shipping carton marking
 - Shipping carton marking shall consist of :
 - 1) Parts name
 - 2) Quantity
- [5] Quantity
 - 2,000 pcs./reel
- [6] Storage environment
 - (1) Before open the packing, we recommend to keep less than +30 °C and 85 %RH of Humidity, and to use it less than 6 months after delivery.
 - (2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 6 month. No need dry air before soldering work if it is less than temperature +30 °C, 85 humidity %RH.
 - (3) Not to expose the sun.
 - (4) Not to storage with some erosive chemicals.
 - (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

[7] Handling

• To handle with care to prevent the damage of tape, reel and products.

- PROCESS QUALITY CONTROL -

No. SG310S*F - 00 - AEE - 5 CRYSTAL OSCILLATOR : SG-310S*F

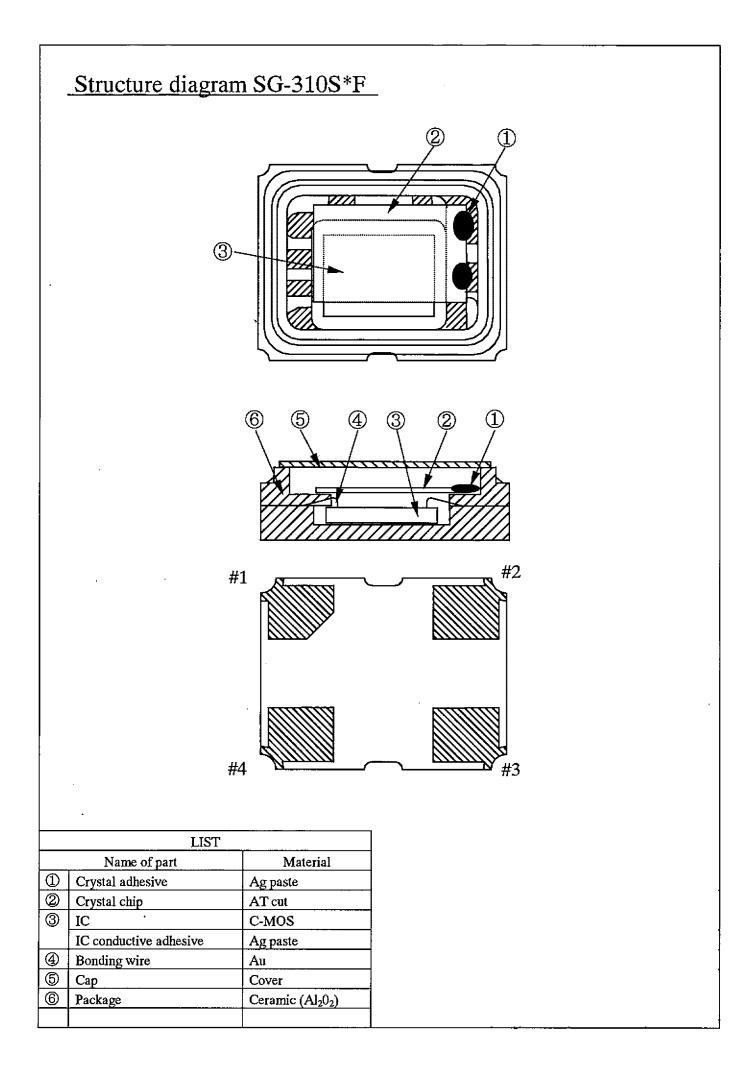
Manufacturing process chart	No.	Section In Charge	Standards	Inspection,	Instruments	Inspection	*12.7.3 Record
		Section in charge		Control Item	inst diretto	Methods	
$ \begin{array}{c c} \text{Lid} & \text{Crystal} & \text{IC} & & & \\ \hline & & & & \\ \hline & & & & \\ \hline & & & &$	1	Inspection Section	Purchasing Specification Incoming Inspection Standard	Appearance Dimension	Microscope	Sampling	Data sheet
1 Inspection 3 Base Set	2	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance Peeling Strength Frequency	Microscope Scratch CI Meter	Sampling	Data sheet
(2) Deposition (4) Parts Mounting (IC)	3	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
(5) Wire Bonding	4	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
	5	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Bonding strength Appearance	Gauge Microscope	Sampling 100% Inspection	Data sheet
6 Crystal-Mounting	6	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	100% Inspection	Data sheet
7 Annealing	7	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
8 Frequency Adjusting (Crystal)	8	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	—	_	—	—
9 Temporary Hermetic Sealing	9	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
10 Hermetic Sealing	10	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance Frequency	Microscope Counter	Sampling Sampling	Data sheet
(11) High Temp Treatment	11	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	_	—	—	—
Fine-Leakage	12	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Leakage Inspection	Measuring equipment	100% Inspection	Data sheet
13 Gross-Leakage	13	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Leakage Inspection	Measuring equipment	100% Inspection	Data sheet
14 Temp Characteristic	14	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Temp Characteristic Inspection	Measuring equipment	Sampling	Data sheet
15 LDL Inspection	15	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Characteristic Inspection	Measuring equipment	100% Inspection	Data sheet
16 Electrical Characteristic	16	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Electrical Characteristic	Measuring equipment	100% Inspection	Data sheet
17 Marking	17	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Visual Inspection	Sampling	Data sheet
Visual Inspection	18	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
19 Outgoing Inspection	19	Malaysia Plant (Inspection Section)	Delivery Specifications Outgoing Inspection Standard	Electrical Characteristic Appearance	Measuring equipment Visual Inspection	Sampling	Data sheet
(20) Taping	20	Malaysia Plant (Production Section)	Manufacturing Instruction Sheet	Tape peeling Strength	Peeling strength test machine	Sampling	Data sheet
(21) Packing	21	Malaysia Plant (Production Control Section)	Manufacturing Instruction Sheet Daily Shipping List	Customers Type Quantity	_	_	Delivery Slip

`12.7.2

No. SG310S*F - 00 - ASE - 2 CRYSTAL OSCILLATOR : SG-310S*F

'05.10. 3

Manufacturing process chart	No.	Section In Charge	Standards	Inspection, Control Item	Instruments	Inspection Methods	Record
$\frac{\text{Lid}}{\nabla} \stackrel{\text{Crystal}}{\nabla} \stackrel{\text{IC}}{\nabla} \stackrel{\text{Base}}{\nabla} \stackrel{\text{(1)}}{\nabla} \stackrel{\text{In-coming}}{\nabla}$	1	Inspection Section	Purchasing Specification Incoming Inspection Standard	Appearance Dimension	Містоѕсоре	Sampling	Data sheet
$\begin{array}{c} \begin{array}{c} \\ 1 \\ 1 \end{array} \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\ 1 \\$	2	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance Peeling Strength Frequency	Microscope Scratch CI Meter	Sampling	Data sheet
	3	China Plant (Production Section)	Manufacturing Instruction Sheet	Арреагансе	Microscope	Sampling	Data sheet
(2) Deposition (4) Parts Mounting (IC)	4	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
(5) Wire Bonding	5	China Plant (Production Section)	Manufacturing Instruction Sheet	Bonding strength Appearance	Gauge Microscope	Sampling 100% Inspection	Data sheet
6 Crystal-Mounting	6	China Plant (Production Section)	Manufacturing Instruction Sheet	Арреагансе	Microscope	100% Inspection	Data sheet
7 Annealing	7	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Microscope	Sampling	Data sheet
8) Frequency Adjusting	8	China Plant (Production Section)	Manufacturing Instruction Sheet				
(Crystal) (9) Cleaning	9	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Visual Inspection	100% Inspection	Data sheet
Ţ	10	China Plant (Production Section)	Manufacturing Instruction Sheet	Арреагадсе	Microscope	Sampling	Data sheet
(10) Temporary Hermetic Sealing	11	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance Frequency	Microscope Counter	Sampling Sampling	Data sheet
(11) Hermetic Sealing	12	China Plant (Production Section)	Manufacturing Instruction Sheet				
(12) High Temp Treatment	13	China Plant (Production Section)	Manufacturing Instruction Sheet	Leakage Inspection	Measuring equipment	100% Inspection	Data sheet
13 Fine-Leakage 14 Gross-Leakage	14	China Plant (Production Section)	Manufacturing Instruction Sheet	Leakage Inspection	Measuring equipment	100% Inspection	Data sheet
15 Temp Characteristic	15	China Plant (Production Section)	Manufacturing Instruction Sheet	Temp Characteristic Inspection	Measuring equipment	Sampling	Data sheet
16 LDL Inspection	16	China Plant (Production Section)	Manufacturing Instruction Sheet	Characteristic Inspection	Measuring equipment	100% Inspection	Data sheet
17 Electrical Characteristic	17	China Plant (Production Section)	Manufacturing Instruction Sheet	Electrical Characteristic	Measuring equipment	100% Inspection	Data sheet
18 Marking	18	China Plant (Production Section)	Manufacturing Instruction Sheet	Appearance	Visual Inspection	Sampling	Data sheet
19 Visual Inspection	19	China Plant (Production Section)	Manufacturing Instruction Sheet	Арреагадсе	Microscope	Sampling	Data sheet
20 Outgoing Inspection	20	China Plant (Inspection Section)	Delivery Specifications Outgoing Inspection Standard	Electrical Characteristic Appearance	Measuring equipment . Visual Inspection	Sampling	Data sheet
21 Taping	21	Chaina Plant (Production Section)	Manufacturing Instruction Sheet	Tape peeling Strength	Peeling strength test machine	Sampling	Data sheet
(22) Packing	22	Chaina Plant (Production Control Section)	Manufacturing Instruction Sheet Daily Shipping List	Customers Type Quantity			Delivery Slip



RELIABILITY TEST DATA Product Name : SG-310 Series

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition . No. IC-G-0521-01-001E

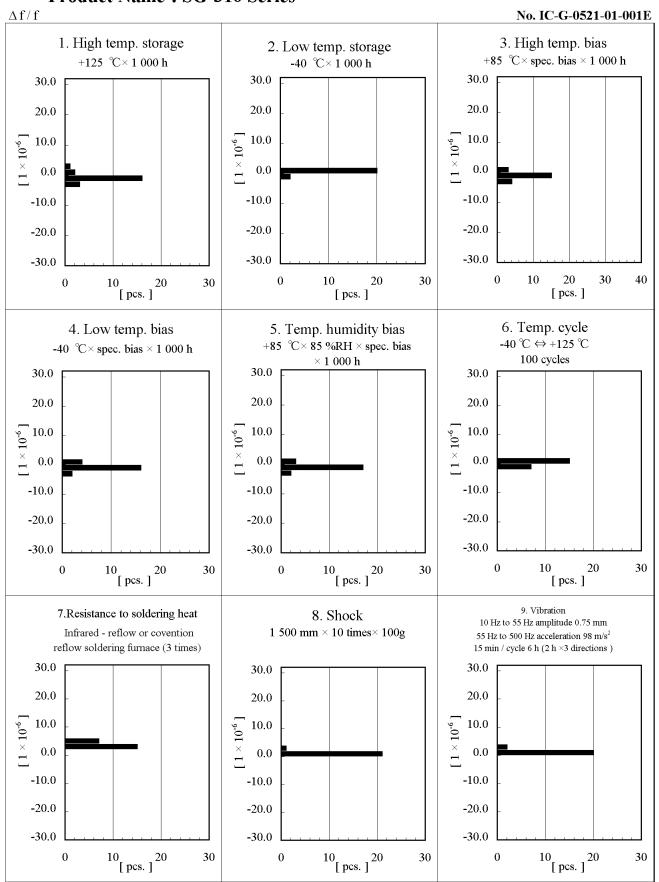
we evaluate environmental and mechanical characteristics by the following test condition .						
			VALUE *1			FAIL
No.	ITEM	TEST CONDITIONS	$\Delta f / f *2$	Electrical	Qty	Qty
			[1 × 10 ⁻⁶]	characteristics	[n]	[n]
1	High temperature storage	+125 °C × 1 000 h	*3 ± 50	Satisfy specification after test	22	0
2	Low temperature storage	-40 °C × 1 000 h	*3 ± 10		22	0
3	High temperature bias	+85 °C × spec. bias × 1 000 h	*3 ± 20		22	0
4	Low temperature bias	-40 °C × spec. bias ×1 000 h	*3 ± 10		22	0
5	Temperature humidity bias	+85 °C × 85 %RH × spec. bias × 1 000 h	*3 ± 20		22	0
6	Temperature cycle	-40 °C \Leftrightarrow +125 °C 30 min. at each temperature 100 cycles	*3 ± 20		22	0
7	Resistance to soldering heat	Infrared - reflow or convention reflow soldering furnace (3 times)	± 10		22	0
8	Shock	100g dummy Jig(Epson Toyocom Standard) drop from 1500mm height on the Concrete 3 directions 10 times	± 5		22	0
9	Vibration	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min./cycle 6 h (2 hours , 3 directions)	± 10		22	0
10	Seal	He leakage detector	$1 \times 10^{-9} \operatorname{Pa} \cdot \mathrm{m}^3/\mathrm{s}$		11	0
11	Pull - off	10 N press for 10 s ± 1 s Ref.EIAJ ED-4702	No peeling-off at a solder part		11	0
12	Solderability	Dip termination into solder bath at $+235 ^{\circ}\text{C} \pm 5 ^{\circ}\text{C}$ for 5s . (Using Rosin Flux)	Termination must be 95 % covered with fresh solder		11	0

Notes

1. *1 Each test done independently.

2. *2 Measuring 2 h to 24 h later leaving in room temperature after each test.

3. *3 Pre conditionings Initial value shall be after 24 h at room temperature after pre-conditioning.



Product Name : SG-310 Series

Qualification Data